Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/699,676	YAMADA ET AL.	
Examiner	Art Unit	
Cuong Q. Nguyen	2811	

SEARCHED					
Class	Subclass	Date	Examiner		
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Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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